













SCES383L-MARCH 2002-REVISED JANUARY 2018

# SN74AUC1G126 Single Bus Buffer Gate With Tri-state Output

#### 1 Features

- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- Available in TI's NanoFree<sup>™</sup> Package
- Optimized for 1.8-V Operation and is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I<sub>off</sub> Supports Partial Power Down Mode and Back Drive Protection
- Sub-1 V Operable
- Maximum t<sub>pd</sub> of 2.5 ns at 1.8 V
- Low Power Consumption, 10-μA Maximum I<sub>CC</sub>
- ±8-mA Output Drive at 1.8 V

## 2 Applications

- AV Receiver
- Audio Dock: Portable
- Blu-ray<sup>™</sup> Player and Home Theater
- Embedded PC
- MP3 Player/Recorder (Portable Audio)
- Personal Digital Assistant (PDA)
- Power: AC/DC Supply, Single Controller
- Solid State Drive (SSD): Client and Enterprise
- TV: LCD, Digital, and High-Definition (HD)
- Tablet: Enterprise
- · Video Analytics: Server
- Wireless Headset, Keyboard, and Mouse

## 3 Description

The SN74AUC1G126 bus buffer gate is operational at 0.8-V to 2.7-V  $V_{CC}$ , but is designed specifically for 1.65-V to 1.95-V  $V_{CC}$  operation.

The SN74AUC1G126 device is a single line driver with a tri-state output. The output is disabled when the output-enable (OE) input is low.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

NanoFree<sup>™</sup> package technology is a major breakthrough in device packaging concepts, using the die as the package.

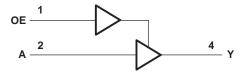
This device is fully specified for partial-power-down applications using  $I_{\rm off}$ . The  $I_{\rm off}$  circuitry disables the outputs, which prevents damaging current backflow through the device when it is powered down.

#### Device Information<sup>(1)</sup>

| PART NUMBER     | PACKAGE    | BODY SIZE (NOM)     |
|-----------------|------------|---------------------|
| SN74AUC1G126DBV | SOT-23 (5) | 2.90 mm × 1.60 mm   |
| SN74AUC1G126DCK | SC70 (5)   | 2.00 mm × 1.25 mm   |
| SN74AUC1G126YZP | DSBGA (5)  | 1.388 mm × 0.888 mm |

 For all available packages, see the orderable addendum at the end of the data sheet.

#### Logic Diagram (Positive Logic)





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## 4 Revision History

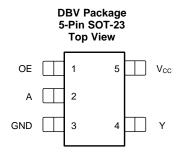
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

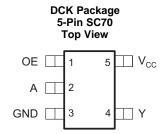
| Changes from Revision K (June 2017) to Revision L                   | Page  |
|---|---|
| Updated body size of YZP package                                    |   |
| Added junction temperature to Absolute Maximum Ratings              |   |
| Add Detailed Description, Application and Implementation, Power St  | upply Recommendations, and Layout sections 12 |
| Changes from Revision J (July 2007) to Revision K                   | Page  |
| Deleted DRY package throughout data sheet                           |   |
| Added Applications, Device Information table, ESD Ratings table, Ti | hermal Information table, Feature Description |

section, Device Functional Modes, Device and Documentation Support section, and Mechanical, Packaging, and

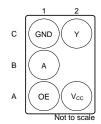


# 5 Pin Configuration and Functions





#### YZP Package 5-Pin DSBGA Bottom View



#### **Pin Functions**

| PIN             |          | 1/0 | DESCRIPTION |                 |  |  |  |
|-----------------|----------|-----|-------------|-----------------|--|--|--|
| NAME            | DBV, DCK | YZP | I/O         | DESCRIPTION     |  |  |  |
| Α               | 2        | B1  | I           | Logic input     |  |  |  |
| GND             | 3        | C1  | _           | Ground          |  |  |  |
| OE              | 1        | A1  | I           | Output enable   |  |  |  |
| V <sub>CC</sub> | 5        | A2  | _           | Positive supply |  |  |  |
| Υ               | 4        | C2  | 0           | Output          |  |  |  |

Product Folder Links: SN74AUC1G126



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|   |   | MIN  | MAX                   | UNIT |
|---|---|------|-----------------------|------|
| Supply voltage, V <sub>CC</sub>                   | -0.5  | 3.6  | V                     |      |
| Input voltage, V <sub>I</sub> <sup>(2)</sup>      |   | -0.5 | 3.6                   | V    |
| Voltage applied to any output in the high-impedar | nce or power-off state, V <sub>O</sub> <sup>(2)</sup> | -0.5 | 3.6                   | V    |
| Output voltage, V <sub>O</sub> <sup>(2)</sup>     |   | -0.5 | V <sub>CC</sub> + 0.5 | V    |
| Input clamp current, I <sub>IK</sub>              | V <sub>I</sub> < 0                                    |      | -50                   | mA   |
| Output clamp current, I <sub>OK</sub>             | V <sub>O</sub> < 0                                    |      | -50                   | mA   |
| Continuous output current, I <sub>O</sub>         |   |      | ±20                   | mA   |
| Continuous current through V <sub>CC</sub> or GND |   |      | ±100                  | mA   |
| Junction temperature, T <sub>J</sub>              |   |      | 150                   | °C   |
| Storage temperature, T <sub>stg</sub>             |   | -65  | 150                   | °C   |

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

|                    |                         |   | VALUE | UNIT |
|--------------------|-------------------------|---|-------|------|
|                    |                         | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)              | ±2000 |      |
| V <sub>(ESD)</sub> | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 (2) | ±1000 | V    |
|                    |                         | Machine Model (A115-A)  | ±200  |      |

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

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<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

|                     |                                    |  | MIN                    | MAX                    | UNIT |
|---------------------|------------------------------------|--|------------------------|------------------------|------|
| V <sub>CC</sub>     | Supply voltage                     |  | 0.8                    | 2.7                    | V    |
|                     |                                    | V <sub>CC</sub> = 0.8 V                      | V <sub>CC</sub>        |                        |      |
| $V_{IH}$            | High-level input voltage           | $V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$  | 0.65 × V <sub>CC</sub> |                        | V    |
|                     |                                    | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$   | 1.7                    |                        |      |
|                     |                                    | V <sub>CC</sub> = 0.8 V                      |                        | 0                      |      |
| $V_{IL}$            | Low-level input voltage            | $V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$  |                        | 0.35 × V <sub>CC</sub> | V    |
|                     |                                    | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$   |                        | 0.7                    |      |
| VI                  | Input voltage                      |  | 0                      | 3.6                    | V    |
| Vo                  | Output voltage                     |  | 0                      | V <sub>CC</sub>        | V    |
|                     |                                    | V <sub>CC</sub> = 0.8 V                      |                        | -0.7                   |      |
|                     |                                    | V <sub>CC</sub> = 1.1 V                      |                        | -3                     |      |
| $I_{OH}$            | High-level output current          | $V_{CC} = 1.4 \text{ V}$                     |                        | <b>-</b> 5             | mA   |
|                     |                                    | V <sub>CC</sub> = 1.65 V                     |                        | -8                     |      |
|                     |                                    | $V_{CC} = 2.3 \text{ V}$                     |                        | <b>-</b> 9             |      |
|                     |                                    | $V_{CC} = 0.8 \text{ V}$                     |                        | 0.7                    |      |
|                     |                                    | V <sub>CC</sub> = 1.1 V                      |                        | 3                      |      |
| $I_{OL}$            | Low-level output current           | $V_{CC} = 1.4 \text{ V}$                     |                        | 5                      | mA   |
|                     |                                    | V <sub>CC</sub> = 1.65 V                     |                        | 8                      |      |
|                     |                                    | $V_{CC} = 2.3 \text{ V}$                     |                        | 9                      |      |
|                     |                                    | $V_{CC} = 0.8 \text{ V to } 1.6 \text{ V}$   |                        | 20                     |      |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ |                        | 10                     | ns/V |
|                     |                                    | $V_{CC}$ = 2.3 V to 2.7 V                    |                        | 3                      |      |
| T <sub>A</sub>      | Operating free-air temperature     |  | -40                    | 85                     | °C   |

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. See *Implications of Slow or Floating CMOS Inputs* application report.

#### 6.4 Thermal Information

|                 | THERMAL METRIC <sup>(1)</sup>          | DBV (SOT-23) | DCK (SC70) | YZP (DSBGA) | UNIT |
|-----------------|--|--------------|------------|-------------|------|
|                 |  | 5 PINS       | 5 PINS     | 5 PINS      |      |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 206          | 252        | 132         | °C/W |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Product Folder Links: SN74AUC1G126



## 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

|                  | PARAMETER                           | TEST CONDITIONS  | MIN            | TYP <sup>(1)</sup> | MAX  | UNIT |
|------------------|-------------------------------------|--|----------------|--------------------|------|------|
|                  |                                     | $I_{OH} = -100 \mu A$ , $V_{CC} = 0.8 \text{ V to } 2.7 \text{ V}$                   | $V_{CC} - 0.1$ |                    |      |      |
|                  |                                     | $I_{OH} = -0.7 \text{ mA}, V_{CC} = 0.8 \text{ V}$                                   |                | 0.55               |      |      |
| \/               | High-level output                   | $I_{OH} = -3 \text{ mA}, V_{CC} = 1.1 \text{ V}$                                     | 0.8            |                    |      | V    |
| V <sub>OH</sub>  | voltage                             | $I_{OH} = -5 \text{ mA}, V_{CC} = 1.4 \text{ V}$                                     | 1              |                    |      | V    |
|                  |                                     | $I_{OH} = -8 \text{ mA}, V_{CC} = 1.65 \text{ V}$                                    | 1.2            |                    |      |      |
|                  |                                     | $I_{OH} = -9 \text{ mA}, V_{CC} = 2.3 \text{ V}$                                     | 1.8            |                    |      |      |
|                  |                                     | $I_{OL} = 100 \ \mu\text{A}, \ V_{CC} = 0.8 \ \text{V} \ \text{to} \ 2.7 \ \text{V}$ |                |                    | 0.2  |      |
|                  | Low-level output voltage            | $I_{OL} = 0.7 \text{ mA}, V_{CC} = 0.8 \text{ V}$                                    |                | 0.25               |      |      |
| \/               |                                     | $I_{OL} = 3 \text{ mA}, V_{CC} = 1.1 \text{ V}$                                      |                |                    | 0.3  | V    |
| V <sub>OL</sub>  |                                     | $I_{OL} = 5 \text{ mA}, V_{CC} = 1.4 \text{ V}$                                      |                |                    | 0.4  | V    |
|                  |                                     | $I_{OL} = 8 \text{ mA}, V_{CC} = 1.65 \text{ V}$                                     |                |                    | 0.45 |      |
|                  |                                     | $I_{OL} = 9 \text{ mA}, V_{CC} = 2.3 \text{ V}$                                      |                |                    | 0.6  |      |
| II               | Inflection-point current            | A or OE input:<br>$V_I = V_{CC}$ or GND, $V_{CC} = 0$ to 2.7 V                       |                |                    | ±5   | μΑ   |
| I <sub>off</sub> | Off-state current                   | $V_{I}$ or $V_{O} = 2.7 \text{ V}, V_{CC} = 0$                                       |                |                    | ±10  | μΑ   |
| I <sub>OZ</sub>  | High-impedance-state output current | $V_O = V_{CC}$ or GND, $V_{CC} = 2.7 \text{ V}$                                      |                |                    | ±10  | μΑ   |
| I <sub>CC</sub>  | Supply current                      | $V_1 = V_{CC}$ or GND, $V_{CC} = 0.8 \text{ V to } 2.7 \text{ V}$ $I_O = 0$          |                |                    | 10   | μΑ   |
| Ci               | Input capacitance                   | $V_I = V_{CC}$ or GND, $V_{CC} = 2.5 \text{ V}$                                      |                | 2.5                |      | pF   |
| Co               | Output capacitance                  | $V_O = V_{CC}$ or GND, $V_{CC} = 2.5 \text{ V}$                                      |                | 5.5                |      | pF   |

<sup>(1)</sup> All typical values are at  $T_A = 25$ °C.



# 6.6 Switching Characteristics: $C_L = 15 pF$

over recommended operating free-air temperature range,  $C_L = 15 \text{ pF}$  (unless otherwise noted) (see Table 2)

|                  | PARAMETER              |                         | TEST CONDITIONS                             | MIN | TYP | MAX | UNIT |
|------------------|------------------------|-------------------------|---|-----|-----|-----|------|
|                  |                        | V <sub>CC</sub> = 0.8 V |   | 4.5 |     |     |      |
|                  |                        |                         | $V_{CC} = 1.2 \text{ V} \pm 0.1 \text{ V}$  | 0.8 |     | 3.6 |      |
| t <sub>pd</sub>  | Propagation delay time | A-to-Y                  | $V_{CC} = 1.5 \text{ V} \pm 0.1 \text{ V}$  | 0.6 |     | 2.3 | ns   |
|                  | dolay timo             |                         | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$ | 0.6 | 1   | 1.6 |      |
|                  |                        |                         | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 0.5 |     | 1.4 |      |
|                  |                        |                         | V <sub>CC</sub> = 0.8 V                     |     | 4.9 |     |      |
|                  |                        | OE-to-Y                 | $V_{CC} = 1.2 \text{ V} \pm 0.1 \text{ V}$  | 0.7 |     | 3.8 |      |
| t <sub>en</sub>  | Enable time            |                         | V <sub>CC</sub> = 1.5 V ± 0.1 V             | 0.7 |     | 2.5 | ns   |
|                  |                        |                         | V <sub>CC</sub> = 1.8 V ± 0.15 V            | 0.3 | 0.9 | 1.9 |      |
|                  |                        |                         | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 0.3 |     | 1.5 |      |
|                  |                        |                         | V <sub>CC</sub> = 0.8 V                     |     | 4.9 |     |      |
|                  |                        |                         | $V_{CC} = 1.2 \text{ V} \pm 0.1 \text{ V}$  | 2.2 |     | 4.7 |      |
| t <sub>dis</sub> | Disable time           | OE-to-Y                 | V <sub>CC</sub> = 1.5 V ± 0.1 V             | 1.8 |     | 4.1 | ns   |
|                  |                        |                         | V <sub>CC</sub> = 1.8 V ± 0.15 V            | 1.6 | 2.4 | 3.5 |      |
|                  |                        |                         | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 1   |     | 2.7 |      |

# 6.7 Switching Characteristics: $C_L = 30 pF$

over recommended operating free-air temperature range,  $C_L = 30 \text{ pF}$  (unless otherwise noted) (see Table 2)

| F                | PARAMETER                             |   | TEST CONDITIONS                             |     | TYP | MAX | UNIT |
|------------------|---------------------------------------|---|---|-----|-----|-----|------|
|                  | Propagation                           | A-to-Y                                      | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$ | 1   | 1.5 | 2.5 | 20   |
| τ <sub>pd</sub>  | delay time                            | A-10-1                                      | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 0.9 |     | 1.7 | ns   |
|                  | t <sub>en</sub> Enable time OE-to-Y   | OE-to-Y                                     | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$ | 1.1 | 1.6 | 2.5 | 20   |
| <sup>L</sup> en  |                                       |   | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 0.9 |     | 1.9 | ns   |
|                  | t <sub>dia</sub> Disable time OF-to-Y | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$ | 1.3   | 2.6 | 3.1 | 20  |      |
| <sup>L</sup> dis |                                       | OE-to-Y                                     | $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$  | 1   |     | 2.1 | ns   |

## 6.8 Operating Characteristics

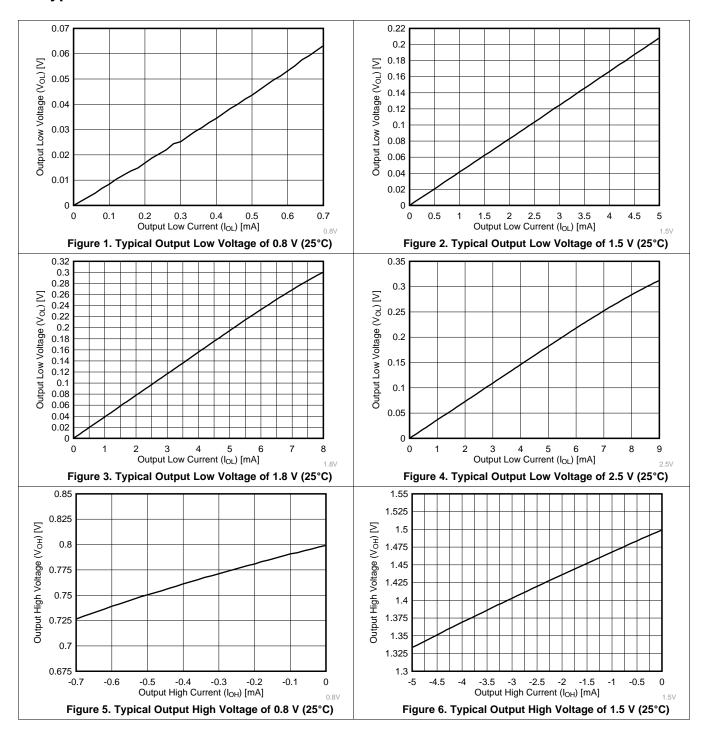
 $T_A = 25$ °C

| PARAMETER                             |            | TEST C              | CONDITIONS               | MIN | TYP | MAX | UNIT |
|---------------------------------------|------------|---------------------|--------------------------|-----|-----|-----|------|
|                                       |            |                     | $V_{CC} = 0.8 \text{ V}$ |     | 14  |     |      |
|                                       |            |                     | V <sub>CC</sub> = 1.2 V  |     | 14  |     |      |
|                                       |            | Inputs<br>disabled  | V <sub>CC</sub> = 1.5 V  |     | 14  |     |      |
|                                       |            | disabica            | V <sub>CC</sub> = 1.8 V  |     | 15  |     |      |
| <ul> <li>Power dissipation</li> </ul> | f = 10 MHz |                     | V <sub>CC</sub> = 2.5 V  |     | 16  |     | , r  |
| C <sub>pd</sub> capacitance           | 1 = 10 MHZ | Outputs<br>disabled | $V_{CC} = 0.8 \text{ V}$ |     | 1.5 |     | pF   |
|                                       |            |                     | V <sub>CC</sub> = 1.2 V  |     | 1.5 |     |      |
|                                       |            |                     | V <sub>CC</sub> = 1.5 V  |     | 1.5 |     |      |
|                                       |            |                     | V <sub>CC</sub> = 1.8 V  |     | 2   |     |      |
|                                       |            |                     | V <sub>CC</sub> = 2.5 V  |     | 2.5 |     |      |

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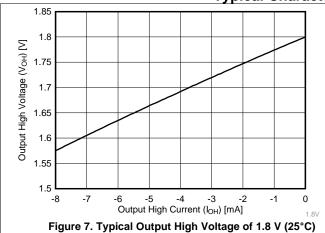


## 7 Typical Characteristics





# **Typical Characteristics (continued)**



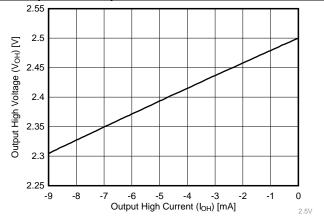


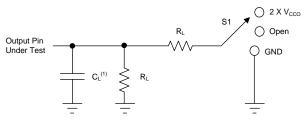
Figure 8. Typical Output High Voltage of 2.5 V (25°C)



## **8 Parameter Measurement Information**

Unless otherwise noted, all input pulses are supplied by generators that have the following characteristics:

- PRR ≤ 10 MHz
- $Z_O = 50 \Omega$



(1) C<sub>L</sub> includes probe and jig capacitance.

Figure 9. Load Circuit

**Table 1. Loading Conditions for Parameter** 

| TEST  | <b>S1</b>           |
|---|---------------------|
| t <sub>PLH</sub> <sup>(1)</sup> , t <sub>PHL</sub> <sup>(1)</sup> | Open                |
| t <sub>PLZ</sub> <sup>(2)</sup> , t <sub>PZL</sub> <sup>(3)</sup> | 2 × V <sub>CC</sub> |
| t <sub>PHZ</sub> <sup>(2)</sup> , t <sub>PZH</sub> <sup>(3)</sup> | GND                 |

Table 2. Loading Conditions for V<sub>CC</sub>

| V <sub>CC</sub> | CL    | R <sub>L</sub> | $V_\Delta$ |
|-----------------|-------|----------------|------------|
| 0.8 V           | 15 pF | 2 kΩ           | 0.1 V      |
| 1.2 V ± 0.1 V   | 15 pF | 2 kΩ           | 0.1 V      |
| 1.5 V ± 0.1 V   | 15 pF | 2 kΩ           | 0.1 V      |
| 1.8 V ± 0.15 V  | 15 pF | 2 kΩ           | 0.15 V     |
| 2.5 V ± 0.2 V   | 15 pF | 2 kΩ           | 0.15 V     |
| 1.8 V ± 0.15 V  | 30 pF | 1 kΩ           | 0.15 V     |
| 2.5 V ± 0.2 V   | 30 pF | 500 kΩ         | 0.15 V     |

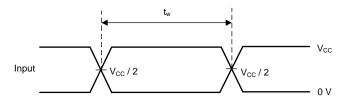
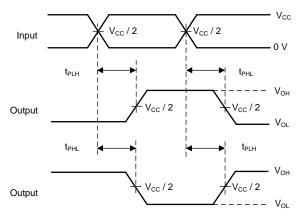


Figure 10. Voltage Waveforms: Pulse Duration

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(1) All outputs are measured one at a time, with one transition per measurement.

Figure 11. Voltage Waveforms: Propagation Delay Times, Inverting and Noninverting Outputs

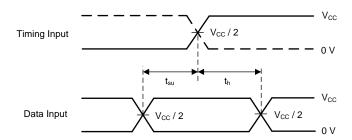
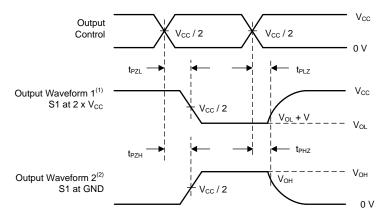


Figure 12. Voltage Waveforms: Setup and Hold Times



- (1) Waveform 1 is for an output with internal conditions such as the output is low, except when disabled by the output control.
- (2) Waveform 2 is for an output with internal conditions such as the output is high, except when disabled by the output control.
- (3) All outputs are measured one at a time, with one transition per measurement.

Figure 13. Voltage Waveforms: Enable and Disable Times, Low- and High-Level Enabling

Product Folder Links: SN74AUC1G126

## 9 Detailed Description

#### 9.1 Overview

The SN74AUC1G126 device contains one buffer gate device with output enable control, and performs the Boolean function Y = A. This device is specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry disables the outputs when the device is powered down. This inhibits current backflow, preventing damage to the device.

To ensure the high-impedance state during power up or power down, OE must be tied to GND through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### 9.2 Functional Block Diagram

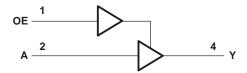


Figure 14. Logic Diagram (Positive Logic)

## 9.3 Feature Description

#### 9.3.1 Balanced CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined the in *Absolute Maximum Ratings* must be followed at all times.

#### 9.3.2 Standard CMOS Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in *Absolute Maximum Ratings*, and the maximum input leakage current, given in *Electrical Characteristics*, using Ohm's law ( $R = V \div I$ ).

Signals applied to the inputs need to have fast edge rates, as defined by  $\Delta t/\Delta v$  in *Recommended Operating Conditions* to avoid excessive current consumption and oscillations. If a slow or noisy input signal is required, a device with a Schmitt-trigger input should be used to condition the input signal prior to the standard CMOS input.

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### Feature Description (continued)

#### 9.3.3 Negative Clamping Diodes

The inputs and outputs to this device have negative clamping diodes as shown in Figure 15.

#### **CAUTION**

Voltages beyond the values specified in *Absolute Maximum Ratings* table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

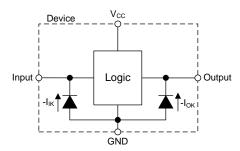


Figure 15. Electrical Placement of Clamping Diodes for Each Input and Output

#### 9.3.4 Special Features

#### 9.3.4.1 Partial Power Down (Ioff)

The inputs and outputs for this device enter a high-impedance state when the supply voltage is 0 V. The maximum leakage into or out of any input or output pin on the device is specified by I<sub>off</sub> in the *Electrical Characteristics*.

#### 9.3.4.2 Overvoltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as the input signals remain below the maximum input voltage value specified in *Recommended Operating Conditions*.

#### 9.3.4.3 Output Enable

This device has an output enable (OE) pin that functions according to Table 3. When the outputs of the device are disabled, the outputs are placed into a high impedance state where the output will neither source nor sink current. High-impedance outputs are also commonly referred to as three-state or tri-state outputs. The maximum leakage for the output in this state is defined by I<sub>OZ</sub> in the *Electrical Characteristics* table.

#### 9.4 Device Functional Modes

Table 3 lists the functional modes of the SN74AUC1G126 device.

**Table 3. Function Table** 

| INPU | JTS | OUTPUT |  |  |  |  |
|------|-----|--------|--|--|--|--|
| OE   | Α   | Υ      |  |  |  |  |
| Н    | Н   | Н      |  |  |  |  |
| Н    | L   | L      |  |  |  |  |
| L    | Χ   | Z      |  |  |  |  |

Product Folder Links: SN74AUC1G126



## 10 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 10.1 Application Information

The SN74AUC1G126 device is an output enabled CMOS buffer that can be used in LED indicator applications that require less than 9 mA. The device can produce up to 9 mA of drive current at 2.5 V. The inputs to the device are also overvoltage tolerant up to 3.6 V, allowing the inputs to translate down to any valid V<sub>CC</sub>.

## 10.2 Typical Application

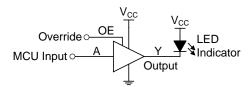


Figure 16. Application Schematic with MCU driving an LED Indicator

#### 10.2.1 Design Requirements

This device uses CMOS technology, and has a balanced output drive. The output drive strength of this device creates fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

#### NOTE

Take care of the output drive to avoid bus contention, because the output can drive currents that exceed maximum limits.

## 10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions:
  - Rise time and fall time specifications ( $\Delta t/\Delta V$ ) are shown in the *Recommended Operating Conditions* table.
  - Specified high (V<sub>IH</sub>) and low voltage (V<sub>IL</sub>) levels are shown in the Recommended Operating Conditions table
  - Inputs are overvoltage tolerant allowing them to go as high as (V<sub>I</sub> maximum) in the Recommended
     Operating Conditions table at any valid V<sub>CC</sub>.
- 2. Recommended Output Conditions:
  - Load currents must not exceed (I<sub>O</sub> max) per output and must not exceed (continuous current through V<sub>CC</sub> or GND) total current for the part. These limits are located in the Absolute Maximum Ratings table.
  - Outputs should not be pulled above V<sub>CC</sub>.

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## **Typical Application (continued)**

#### 10.2.3 Application Curve

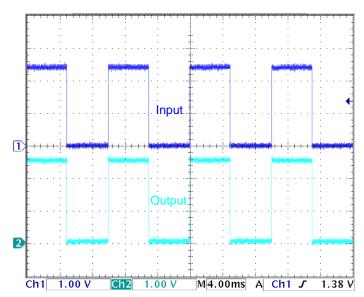


Figure 17. Example Oscilloscope Waveform

## 11 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating listed in the *Recommended Operating Conditions* table.

The  $V_{CC}$  pin must have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended, and it is ok to parallel multiple bypass caps to reject different frequencies of noise. 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor must be installed as close as possible to the power pin for best results.

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## 12 Layout

## 12.1 Layout Guidelines

Even low data rate digital signals can contain high-frequency signal components due to fast edge rates. When a printed-circuit board (PCB) trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self–inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. Figure 18 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

#### 12.2 Layout Example

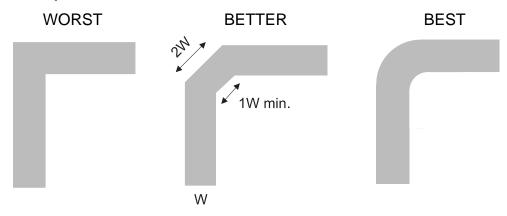


Figure 18. Trace Example

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## 13 Device and Documentation Support

## 13.1 Documentation Support

#### 13.1.1 Related Documentation

For related documentation see the following:

Texas Instruments, Implications of Slow or Floating CMOS Inputs application report

### 13.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 13.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 13.4 Trademarks

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#### 13.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 13.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

### 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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## PACKAGE OPTION ADDENDUM

10-Dec-2020

#### **PACKAGING INFORMATION**

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| Orderable Device | Status (1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan     | Lead finish/<br>Ball material | MSL Peak Temp      | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|------------|--------------|--------------------|------|----------------|--------------|-------------------------------|--------------------|--------------|----------------------|---------|
| 74AUC1G126DCKRG4 | ACTIVE     | SC70         | DCK                | 5    | 3000           | RoHS & Green | NIPDAU                        | Level-1-260C-UNLIM | -40 to 85    | UNR                  | Samples |
| SN74AUC1G126DBVR | ACTIVE     | SOT-23       | DBV                | 5    | 3000           | RoHS & Green | NIPDAU                        | Level-1-260C-UNLIM | -40 to 85    | U26R                 | Samples |
| SN74AUC1G126DCKR | ACTIVE     | SC70         | DCK                | 5    | 3000           | RoHS & Green | NIPDAU                        | Level-1-260C-UNLIM | -40 to 85    | UNR                  | Samples |
| SN74AUC1G126YZPR | ACTIVE     | DSBGA        | YZP                | 5    | 3000           | RoHS & Green | SNAGCU                        | Level-1-260C-UNLIM | -40 to 85    | (UN, UNN)            | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

10-Dec-2020

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 18-Jan-2020

## TAPE AND REEL INFORMATION





|    | Dimension designed to accommodate the component width     |
|----|---|
|    | Dimension designed to accommodate the component length    |
|    | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

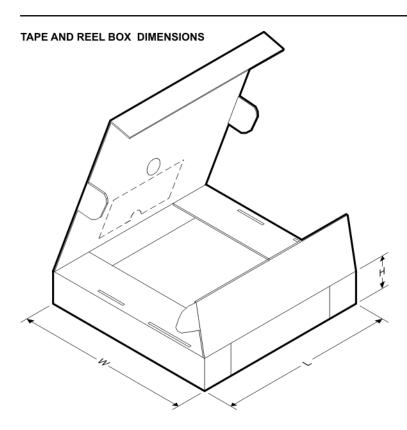
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device           | Package<br>Type | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74AUC1G126DBVR | SOT-23          | DBV                | 5 | 3000 | 180.0                    | 8.4                      | 3.23       | 3.17       | 1.37       | 4.0        | 8.0       | Q3               |
| SN74AUC1G126DCKR | SC70            | DCK                | 5 | 3000 | 180.0                    | 8.4                      | 2.47       | 2.3        | 1.25       | 4.0        | 8.0       | Q3               |
| SN74AUC1G126YZPR | DSBGA           | YZP                | 5 | 3000 | 178.0                    | 9.2                      | 1.02       | 1.52       | 0.63       | 4.0        | 8.0       | Q1               |

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\*All dimensions are nominal

| 7 III GITTIOTOTOTO GITO TTOTTIITIGI |              |                 |      |      |             |            |             |
|-------------------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device                              | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
| SN74AUC1G126DBVR                    | SOT-23       | DBV             | 5    | 3000 | 202.0       | 201.0      | 28.0        |
| SN74AUC1G126DCKR                    | SC70         | DCK             | 5    | 3000 | 202.0       | 201.0      | 28.0        |
| SN74AUC1G126YZPR                    | DSBGA        | YZP             | 5    | 3000 | 220.0       | 220.0      | 35.0        |

# DCK (R-PDSO-G5)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AA.



# DCK (R-PDSO-G5)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.





SMALL OUTLINE TRANSISTOR



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

<sup>8.</sup> Board assembly site may have different recommendations for stencil design.



DIE SIZE BALL GRID ARRAY



### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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